

<b>Notice of References Cited</b>	Application/Control No. 10/784,975		Applicant(s)/Patent Under Reexamination ARNTZ ET AL.	
	Examiner Philip H Leung		Art Unit 3742	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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X	B	US-4,780,596	10-1988	Matsushima et al.	219/400
X	C	US-5,485,780	01-1996	Koether et al.	219/400
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	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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